SN54LS21, SN74LS21 DUAL 4-INPUT POSITIVE AND GATES

APRIL 1985 - REVISED MARCH 1988

SDLS139

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

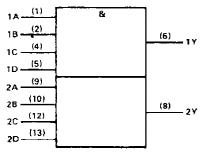
These devices contain two independent 4-input AND gates.

The SN54LS21 is characterized for operation over the full military temperature range of -55 °C to 125 °C. The SN74LS21 is characterized for operation from 0 °C to 70 °C.

FUNCTION	TABLE	{each	gate)
----------	-------	-------	-------

	INP	UTS	OUTPUT	
A	в	С	D	Y
н	Н	н	Н	н
L	х	х	x	L
х	L	х	×	L
х	х	Ł	х	L
х	х	х	L	L

logic symbol[†]



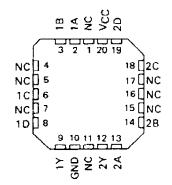
[†] This symbol is in accordance with ANSI/IEEE Std 91 1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W peckages.

SN54LS21 ... J OR W PACKAGE SN74LS21 ... D OR N PACKAGE (TOP VIEW) 1A 1 141 VCC 1B 2 132 2D NC 3 121 2C

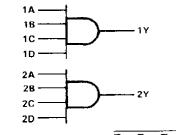
ni C	43	·
1C	[]₄	
1D	□ 5	10] 2B
1Y	Цe	9] 2A
GND	d،	8]] 2Y

SN54LS21 . . . FK PACKAGE (TOP VIEW)



NC-No internal connection

logic diagram



(positive logic) Y = A+B+C+D or Y = $\overline{\overline{A} + \overline{B} + \overline{C} + \overline{D}}$

PRODUCTION UAL (a sents contain information current as of a M (a sents) contain the specifications per (a set of Texas instruments standard warrant). Provention processing does not necessarily inclusive testing of all parameters.

TEXAS TEXAS INSTRUMENTS

SN54LS21, SN74LS21 DUAL 4-INPUT POSITIVE-AND GATES

schematics (each gate) Vcc 20 k Ω \$10 kΩ **ξ**8kΩ **ξ** 120 Ω INPUTS A в С D 5kΩ £ ζ_{3 kΩ} **ξ** 1.5 kΩ GND ሕ

Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	,	
Input voltage		
Operating free-air temperature range:	SN54'	
·		
Storage temperature range		

NOTE 1: Voltage values are with respect to network ground terminals.



SN54LS21, SN74LS21 **DUAL 4-INPUT POSITIVE-AND GATES**

···· · · · · · · · · · · · · ·

recommended operating conditions

		SN54LS21]			
_	MIN		NOM	MAX	MIN	NOM	MAX	UNIT
VCC Supply voltage	4.5		5	5.5	4.75	5	5.25	V
VIH High-level input voltage	2				2			v
VIL Low-level input voltage				0.7	1		0.8	v
IOH High-level output current				- 0.4			- 0.4	mA
IOL Low-level output current				4	<u> </u>		8	mA
T _A Operating free-air temperature	- 55			125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER					<u> </u>					
		TEST CONDITIONS [†]		MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
Vικ	V _{CC} = MIN,	lj ÷ − 18 mA				- 1.5			- 1.5	v
VOH	V _{CC} ≈ MIN,	V _{IH} ≭ 2 V,	¹ OH = - 0.4 mA	2.5	3,4		2.7	3.4		V
	V _{CC} = MIN,	VIL = MAX,	lot = 4 mA		0.25	0.4		0.25	0.4	- v
VOL	V _{CC} ≈ MIN,	V _{IL} = MAX,	I _{OL} = 8 mA				r -	0.35	0.5	
1	V _{CC} ≊ MAX,	V ₁ = 7 V				0.1			0.1	mA
IIH	V _{CC} = MAX,	V ₁ - 2.7 V		1		20	[20	μА
لېر	V _{CC} = MAX,	V ₁ = 0.4 V			-	- 0.4			- 0.4	mA
los §	Vcc = MAX			- 20		- 100	- 20		- 100	mA
ICCH	V _{CC} = MAX,	V ₁ = 4.5 V	<u> </u>		1.2	2.4		1.2	2.4	mA
ICCL	V _{CC} = MAX,	v _i = 0 v			2.2	4.4	1	2.2	4,4	mА

t For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at V_{CC} = 5 V, T_A = 25°C § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$ (see note 2)

PARAMETER	FROM (INPUT)	то (оитрит)	TEST CONDITIONS	MIN	түр	мах	UNIT
tPLH	Any				8	15	ns
ΦHL			R _L ≃2kΩ, C _L =15pF		10	20	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated